TOSHIBA RF POWER AMPLIFIER MODULE

S-AV23AL, S-AV23AH, S-AV23AVH

VHF POWER AMPLIFIER MODULE

S-AV23AL : $f = 135 \sim 150 MHz$

S-AV23AH : $f = 150 \sim 163 MHz$

S-AV23AVH : $f=160\sim175MHz$

MAXIMUM RATINGS (Tc = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
DC Supply Voltage	v_{CC}	11	V
DC Supply Voltage	$V_{ m BB}$	6	V
Input Power	Pi	400	mW
Operating Case Temperature Range	T _{c (opr)}	-30~100	°C
Storage Temperature Range	$T_{ m stg}$	-40~110	°C

26.6 \pm 0.2 $2-R1.5\pm0.2$ 22.0 \pm 0.5 6.1 \pm 1 11.2 \pm 1 21.3 ± 1 $125_{-0.03}^{+0.5}$ 23.9 ± 1 S. 5MAX INPUT V_{BB} 2. v_{CC} OUTPUT GROUND (FLANGE) **JEDEC** EIAJ TOSHIBA 5-22K

Weight: 3.5g

ELECTRICAL CHARACTERISTICS ($Tc = 25^{\circ}C$)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Frequency Range	f_{range}		135	_	175	MHz
Output Power	Po		2.7	_	_	w
Power Gain	Gp	Pi=200mW	11.3	_	_	dB
Total Efficiency	$\eta_{\mathbf{T}}$	$V_{\rm CC}$ =7.5V, $V_{\rm BB}$ =5V	35	_	_	%
Input VSWR	VSWRin	$Z_{G}=Z_{L}=50\Omega$	_	1.5	2.5	_
Harmonics	HRM		_	_	-20	dB
Load Mismatch	_	$egin{array}{c} V_{CC}=9V \\ V_{BB}=5V \\ Pi=200mW \\ VSWR \ load \ 20:1 \ all \ phase \\ \end{array}$	No Degradation		_	
Stability	_	$V_{CC}=6\sim9V$ $V_{BB}=5V$ Pi=200mW $VSWR\ load\ 6:1\ all\ phase$	All spurious output than 60dB below desired signal			

CAUTION

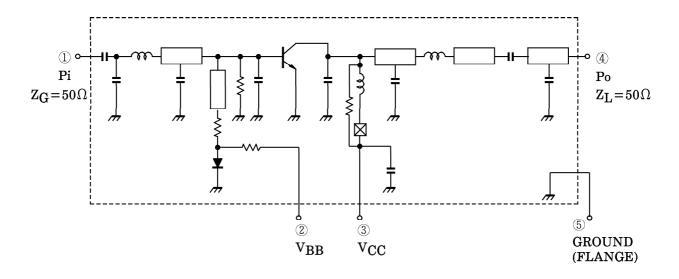
This product has intersetting cap. Please pay attention for exceeding stress and foreign matter in your application. And not to take away the cap.

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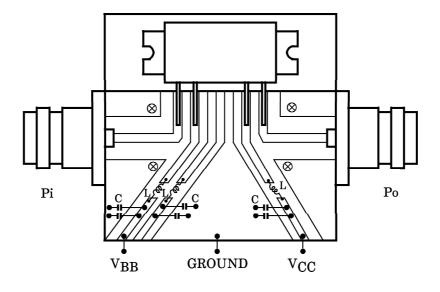
TOSHIBA Semiconductor Reliability Handbook.

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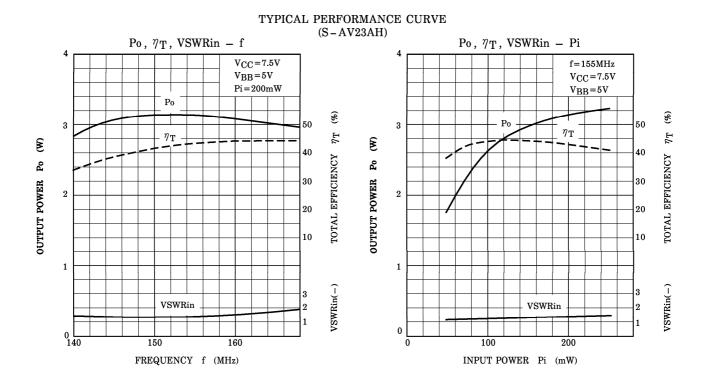
SCHEMATIC

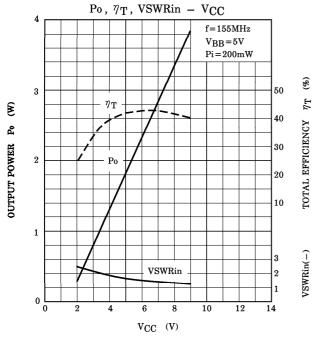


TEST FIXTURE



C : 22000pF, 10μ F PARALLEL L : ϕ 0.5 ENAMEL WIRE 3ID, 5T





CAUTION

These are only typical curves and devices are not necessarily guaranteed at these curves.